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| Notice of References Cited | Application/Control No. 10/678,248 | Applicant(s)/Patent Under Reexamination ZATLOUKAL ET AL. | |
| | Examiner Chuck O. Kendall | Art Unit 2192 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|-------------------------------|----------------|
| * | A | US-2003/0028364 | 02-2003 | Chan et al. | 704/1 |
| * | B | US-2003/0236657 | 12-2003 | Ryzl, Martin | 703/23 |
| * | C | US-6,314,559 | 11-2001 | Sollich, Peter Franz Valentin | 717/111 |
| * | D | US-7,076,772 | 07-2006 | Zatloukal, Kevin | 717/147 |
| | E | US- | | | |
| | F | US- | | | |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
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| | N | | | | | |
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| | P | | | | | |
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| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

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